## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10676943	OCHIAI ET AL.
Examiner	Art Unit
NAM HUYNH	2617

SEARCHED							
Class	Subclass	Date	Examiner				
340	539.11-13, 5.2, 5.9-5.92	3/24/2008	NTH				
705	17, 65-68	3/24/2008	NTH				
455	410	3/24/2008	NTH				
345	173	3/24/2008	NTH				
341	20, 22, 31, 32	3/24/2008	NTH				

SEARCH NOTES					
Search Notes	Date	Examiner			
See EAST search notes.	3/24/2008	NTH			
Interference search conducted	3/24/2008	NTH			
Consulted with Examiner Benjamin Lee regarding search area and allowable subject matter.	3/24/2008	NTH			

INTERFERENCE SEARCH					
Class	S	Subclass	Date	Examiner	
See	Above		3/24/2008	NTH	

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